



# HIRF740 / HIRF740F

N-Channel Power MOSFET (400V, 10A)

## Description

This N-Channel MOSFETs provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

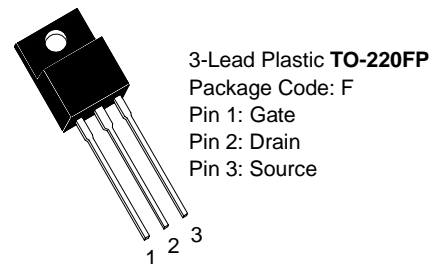
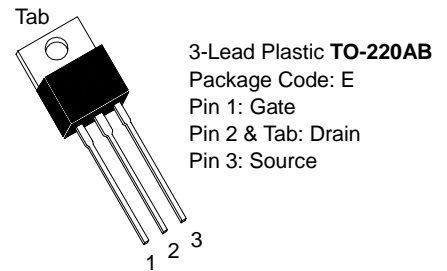
## Features

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements

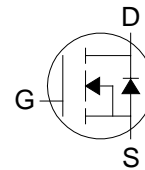
## Thermal Characteristics

| Symbol         | Parameter                                   | Value    |      | Units |
|----------------|---|----------|------|-------|
| $R\theta_{JC}$ | Thermal Resistance Junction to Case Max.    | TO-220AB | 1.71 | °C/W  |
|                |   | TO-220FP | 3.3  |       |
| $R\theta_{JA}$ | Thermal Resistance Junction to Ambient Max. | 62       |      | °C/W  |

### HIRF740 Series Pin Assignment



### HIRF740 Series Symbol



## Absolute Maximum Ratings

| Symbol         | Parameter   | Value      | Units |
|----------------|---|------------|-------|
| $V_{DSS}$      | Drain-Source Voltage  | 400        | V     |
| $I_D$          | Drain to Current (Continuous)( $V_{GS}@10V, T_C=25^\circ C$ )                   | 10         | A     |
|                | Drain to Current (Continuous)( $V_{GS}@10V, T_C=100^\circ C$ )                  | 6.3        | A     |
| $I_{DM}$       | Drain to Current (Pulsed) <sup>*1</sup>   | 40         | A     |
| $V_{GS}$       | Gate-to-Source Voltage (Continue)   | ±20        | V     |
| $P_D$          | Total Power Dissipation   |            |       |
|                | TO-220AB  | 74         | W     |
|                | TO-220FP  | 38         |       |
|                | Derate above 25°C   |            |       |
|                | TO-220AB  | 0.59       | W/°C  |
|                | TO-220FP  | 0.3        |       |
| $E_{AS}$       | Single Pulse Avalanche Energy <sup>*2</sup>                                     | 520        | mJ    |
| $I_{AR}$       | Avalanche Current <sup>*1</sup>   | 10         | A     |
| $E_{AR}$       | Repetitive Avalanche Energy <sup>*1</sup>                                       | 13         | mJ    |
| $d_v/d_t$      | Peak Diode Recovery <sup>*3</sup>   | 4          | V/ns  |
| $T_J, T_{stg}$ | Operating Junction and Storage Temperature Range                                | -55 to 150 | °C    |
| $T_L$          | Maximum Lead Temperature for Soldering Purposes, 1.6mm from case for 10 seconds | 300        | °C    |

\*1: Repetitive rating; pulse width limited by max. junction temperature

\*2:  $V_{DD}=50V$ , starting  $T_J=25^\circ C$ ,  $L=9.1mH$ ,  $R_G=25\Omega$ ,  $I_{AS}=10A$

\*3:  $I_{SD}\leq 10A$ ,  $di/dt\leq 120A/us$ ,  $V_{DD}\leq V_{(BR)DSS}$ ,  $T_J\leq 150^\circ C$



### Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise specified)

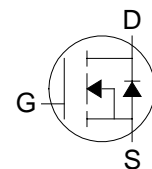
| Symbol                          | Characteristic  | Min. | Typ. | Max. | Unit               |
|---------------------------------|---|------|------|------|--------------------|
| $V_{(BR)DSS}$                   | Drain-Source Breakdown Voltage ( $V_{GS}=0V, I_D=250\mu A$ )                                    | 400  | -    | -    | V                  |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient (Reference to $25^\circ\text{C}$ , $I_D=1\text{mA}$ )       | -    | 0.49 | -    | $V/^\circ\text{C}$ |
| $I_{DSS}$                       | Drain-Source Leakage Current ( $V_{DS}=400V, V_{GS}=0V$ )                                       | -    | -    | 25   | $\mu A$            |
|                                 | Drain-Source Leakage Current ( $V_{DS}=320V, V_{GS}=0V, T_J=125^\circ\text{C}$ )                |      |      | 250  | $\mu A$            |
| $I_{GSSF}$                      | Gate-Source Leakage Current-Forward ( $V_{gsf}=20V, V_{DS}=0V$ )                                | -    | -    | 100  | nA                 |
| $I_{GSSR}$                      | Gate-Source Leakage Current-Reverse ( $V_{gsr}=-20V, V_{DS}=0V$ )                               | -    | -    | -100 | nA                 |
| $V_{GS(th)}$                    | Gate Threshold Voltage ( $V_{DS}=V_{GS}, I_D=250\mu A$ )  | 2    | -    | 4    | V                  |
| $R_{DS(on)}$                    | Static Drain-Source On-Resistance ( $V_{GS}=10V, I_D=6A$ ) <sup>*4</sup>                        | -    | -    | 0.55 | $\Omega$           |
| $g_{FS}$                        | Forward Transconductance ( $V_{DS}=50V, I_D=6A$ ) <sup>*4</sup>                                 | 5.8  | -    | -    | S                  |
| $C_{iss}$                       | Input Capacitance   | -    | 1400 | -    | pF                 |
| $C_{oss}$                       | Output Capacitance  | -    | 330  | -    |                    |
| $C_{rss}$                       | Reverse Transfer Capacitance  | -    | 120  | -    |                    |
| $t_{d(on)}$                     | Turn-on Delay Time  | -    | 14   | -    | ns                 |
| $t_r$                           | Rise Time   | -    | 27   | -    |                    |
| $t_{d(off)}$                    | Turn-off Delay Time   | -    | 50   | -    |                    |
| $t_f$                           | Fall Time   | -    | 24   | -    |                    |
| $Q_g$                           | Total Gate Charge   | -    | -    | 63   | nC                 |
| $Q_{gs}$                        | Gate-Source Charge  | -    | -    | 9    |                    |
| $Q_{gd}$                        | Gate-Drain Charge   | -    | -    | 32   |                    |
| $L_D$                           | Internal Drain Inductance (Measured from the drain lead 0.25" from package to center of die)    | -    | 4.5  | -    | nH                 |
| $L_S$                           | Internal Source Inductance (Measured from the drain lead 0.25" from package to source bond pad) | -    | 7.5  | -    | nH                 |

\*4: Pulse Test: Pulse Width $\leq 300\mu s$ , Duty Cycle $\leq 2\%$

### Source-Drain Diode

| Symbol   | Characteristic                                   | Min. | Typ. | Max. | Units   |
|----------|--|------|------|------|---------|
| $I_S$    | Continuous Source Current (Body Diode)           | -    | -    | 10   | A       |
| $I_{SM}$ | Pulsed Source Current (Body Diode) <sup>*1</sup> | -    | -    | 40   | A       |
| $t_{rr}$ | Reverse Recovery Time                            | -    | 370  | 790  | ns      |
| $Q_{rr}$ | Reverse Recovery Charge                          | -    | 3.8  | 8.2  | $\mu C$ |
| $V_{SD}$ | Diode Forward Voltage                            | -    | -    | 2    | V       |
| $t_{on}$ | Forward Turn-On Time                             | -    | **   | -    |         |

\*\* : Negligible, Dominated by circuit inductance





### TO-220AB Dimension

3-Lead TO-220AB  
Plastic Package  
HSMC Package Code: E

Marking:

Pb Free Mark  
Pb-Free: "●" (Note)  
Normal: None

Date Code

Control Code

Note: Green label is used for pb-free packing

Pin Style: 1.Gate 2 & Tab.Drain 3.Source

Material:

- Lead solder plating: Sn60/Pb40 (Normal), Sn/3.0Ag/0.5Cu or Pure-Tin (Pb-free)
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0

| DIM | Min.  | Max.   |
|-----|-------|--------|
| A   | 5.58  | 7.49   |
| B   | 8.38  | 8.90   |
| C   | 4.40  | 4.70   |
| D   | 1.15  | 1.39   |
| E   | 0.35  | 0.60   |
| F   | 2.03  | 2.92   |
| G   | 9.66  | 10.28  |
| H   | -     | *16.25 |
| I   | -     | *3.83  |
| J   | 3.00  | 4.00   |
| K   | 0.75  | 0.95   |
| L   | 2.54  | 3.42   |
| M   | 1.14  | 1.40   |
| N   | -     | *2.54  |
| O   | 12.70 | 14.27  |
| P   | 14.48 | 15.87  |

\*: Typical, Unit: mm

### TO-220FP Dimension

3-Lead TO-220FP  
Plastic Package  
HSMC Package Code: F

Marking:

Pb Free Mark  
Pb-Free: "●" (Note)  
Normal: None

Date Code

Control Code

Note: Green label is used for pb-free packing

Pin Style: 1.Gate 2.Drain 3.Source

Material:

- Lead solder plating: Sn60/Pb40 (Normal), Sn/3.0Ag/0.5Cu or Pure-Tin (Pb-free)
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0

| DIM              | Min.  | Max.  |
|------------------|-------|-------|
| A                | 6.48  | 7.40  |
| C                | 4.40  | 4.90  |
| D                | 2.34  | 3.00  |
| E                | 0.45  | 0.80  |
| F                | 9.80  | 10.36 |
| G                | 3.10  | 3.60  |
| I                | 2.70  | 3.43  |
| J                | 0.60  | 1.00  |
| K                | 2.34  | 2.74  |
| L                | 12.48 | 13.60 |
| M                | 15.67 | 16.20 |
| N                | 0.90  | 1.47  |
| O                | 2.00  | 2.96  |
| $\alpha 1/2/4/5$ | -     | *5°   |
| $\alpha 3$       | -     | *27°  |

\*: Typical, Unit: mm

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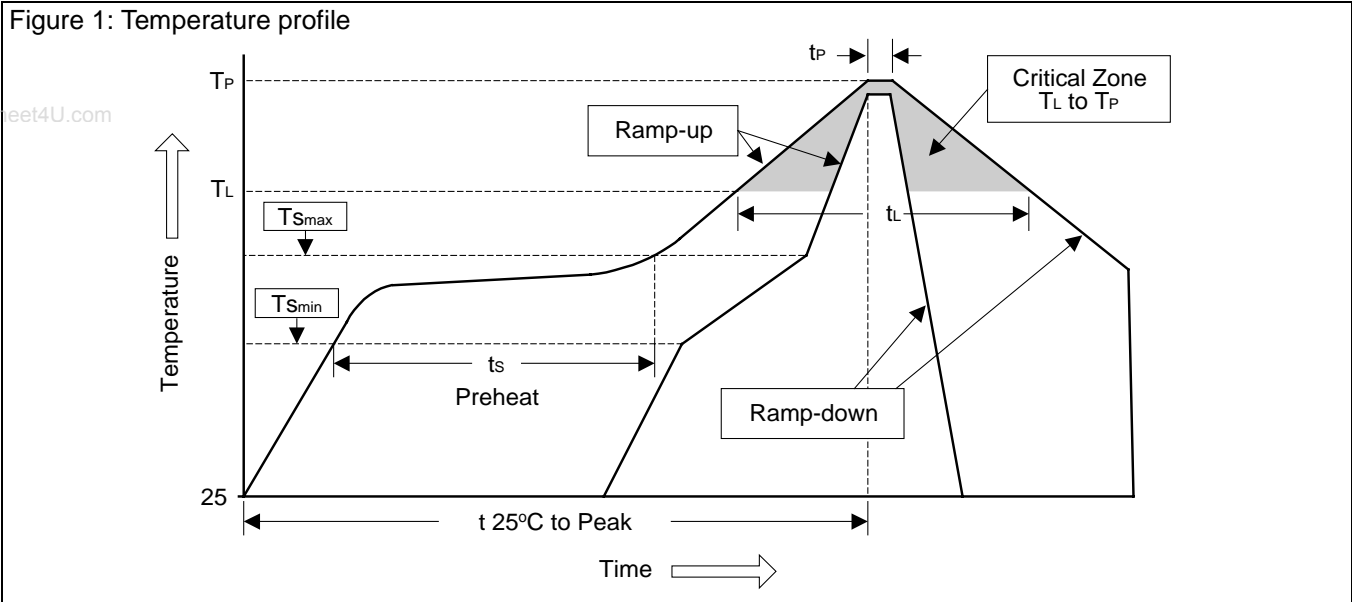
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### Soldering Methods for HSMC's Products

1. Storage environment: Temperature=10°C~35°C Humidity=65%±15%
2. Reflow soldering of surface-mount devices



| Profile Feature                                      | Sn-Pb Eutectic Assembly | Pb-Free Assembly |
|--|-------------------------|------------------|
| Average ramp-up rate ( $T_L$ to $T_P$ )              | <3°C/sec                | <3°C/sec         |
| Preheat  |                         |                  |
| - Temperature Min ( $T_{smin}$ )                     | 100°C                   | 150°C            |
| - Temperature Max ( $T_{smax}$ )                     | 150°C                   | 200°C            |
| - Time (min to max) ( $t_s$ )                        | 60~120 sec              | 60~180 sec       |
| $T_{smax}$ to $T_L$                                  |                         |                  |
| - Ramp-up Rate                                       | <3°C/sec                | <3°C/sec         |
| Time maintained above:                               |                         |                  |
| - Temperature ( $T_L$ )                              | 183°C                   | 217°C            |
| - Time ( $t_L$ )                                     | 60~150 sec              | 60~150 sec       |
| Peak Temperature ( $T_P$ )                           | 240°C +0/-5°C           | 260°C +0/-5°C    |
| Time within 5°C of actual Peak Temperature ( $t_p$ ) | 10~30 sec               | 20~40 sec        |
| Ramp-down Rate                                       | <6°C/sec                | <6°C/sec         |
| Time 25°C to Peak Temperature                        | <6 minutes              | <8 minutes       |

### 3. Flow (wave) soldering (solder dipping)

| Products         | Peak temperature | Dipping time |
|------------------|------------------|--------------|
| Pb devices.      | 245°C ±5°C       | 5sec ±1sec   |
| Pb-Free devices. | 260°C +0/-5°C    | 5sec ±1sec   |